

# FDMS8023S-VB Datasheet

## N-Channel 30 V (D-S) MOSFET

| PRODUCT SUMMARY |                           |                           |              |
|-----------------|---------------------------|---------------------------|--------------|
| $V_{DS}$ (V)    | $R_{DS(on)}$ ( $\Omega$ ) | $I_D$ (A) <sup>a, e</sup> | $Q_g$ (Typ.) |
| 30              | 0.003 at $V_{GS} = 10$ V  | 120                       | 71 nC        |
|                 | 0.005 at $V_{GS} = 4.5$ V | 90                        |              |

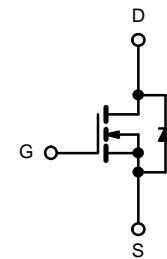
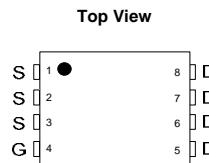
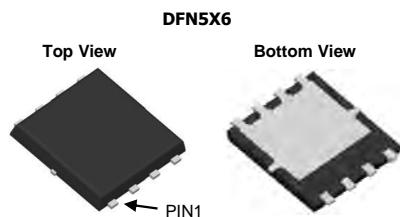
### FEATURES

- TrenchFET® Power MOSFET
- 100 %  $R_g$  and UIS Tested



### APPLICATIONS

- Notebook PC Core
- VRM/POL



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS ( $T_A = 25$ °C, unless otherwise noted) |                |                      |      |
|---|----------------|----------------------|------|
| Parameter   | Symbol         | Limit                | Unit |
| Drain-Source Voltage  | $V_{DS}$       | 30                   | V    |
| Gate-Source Voltage   | $V_{GS}$       | $\pm 20$             |      |
| Continuous Drain Current ( $T_J = 175$ °C)                        | $T_C = 25$ °C  | 120 <sup>a, e</sup>  | A    |
|   | $T_C = 70$ °C  | 90 <sup>e</sup>      |      |
|   | $T_A = 25$ °C  | 21 <sup>b, c</sup>   |      |
|   | $T_A = 70$ °C  | 20.8 <sup>b, c</sup> |      |
| Pulsed Drain Current  | $I_{DM}$       | 250                  |      |
| Avalanche Current Pulse   | $I_{AS}$       | 56                   | mJ   |
| Single Pulse Avalanche Energy                                     | $E_{AS}$       | 60                   |      |
| Continuous Source-Drain Diode Current                             | $T_C = 25$ °C  | 80 <sup>a, e</sup>   | A    |
|   | $T_A = 25$ °C  | 76 <sup>b, c</sup>   |      |
| Maximum Power Dissipation   | $T_C = 25$ °C  | 210 <sup>a</sup>     | W    |
|   | $T_C = 70$ °C  | 155                  |      |
|   | $T_A = 25$ °C  | 35 <sup>b, c</sup>   |      |
|   | $T_A = 70$ °C  | 13 <sup>b, c</sup>   |      |
| Operating Junction and Storage Temperature Range                  | $T_J, T_{stg}$ | -55 to 175           | °C   |

| THERMAL RESISTANCE RATINGS                  |              |            |         |      |
|---|--------------|------------|---------|------|
| Parameter                                   | Symbol       | Typical    | Maximum | Unit |
| Maximum Junction-to-Ambient <sup>b, d</sup> | $R_{thJA}$   | 41         | 50      | °C/W |
| Maximum Junction-to-Case                    | Steady State | $R_{thJC}$ | 0.7     |      |

Notes:

a. Based on  $T_C = 25$  °C.

b. Surface mounted on 1" x 1" FR4 board.

c.  $t = 10$  s.

d. Maximum under steady state conditions is 90 °C/W.

e. Calculated based on maximum junction temperature. Package limitation current is 80 A.

**SPECIFICATIONS** ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

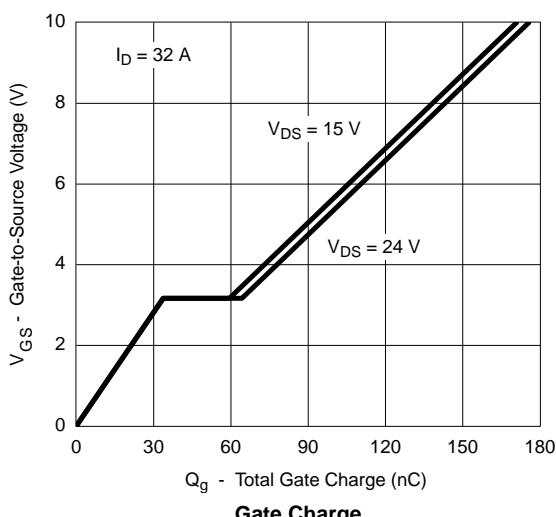
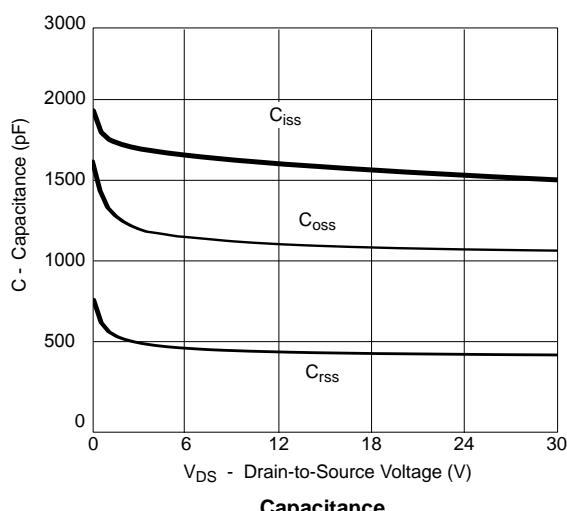
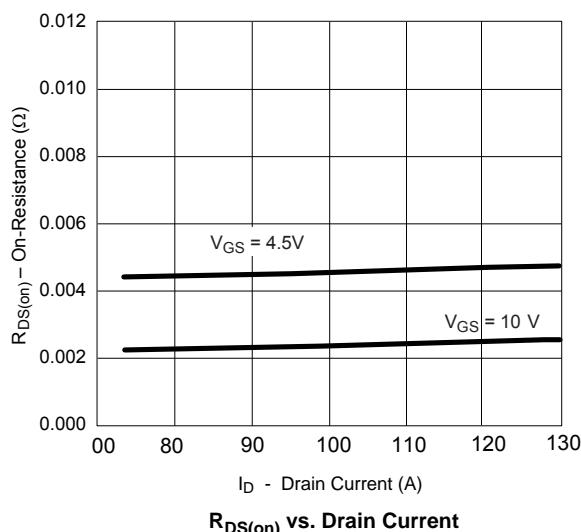
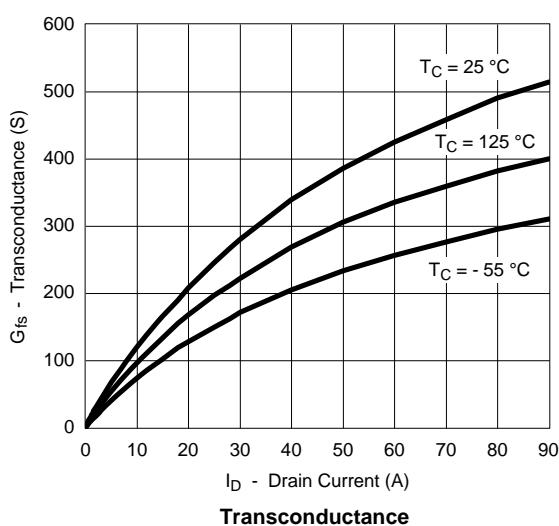
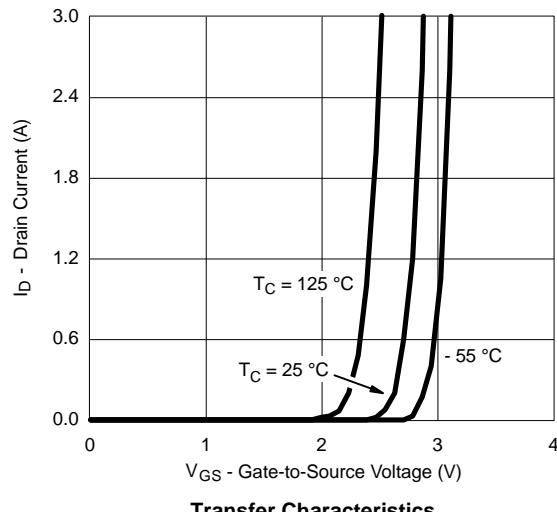
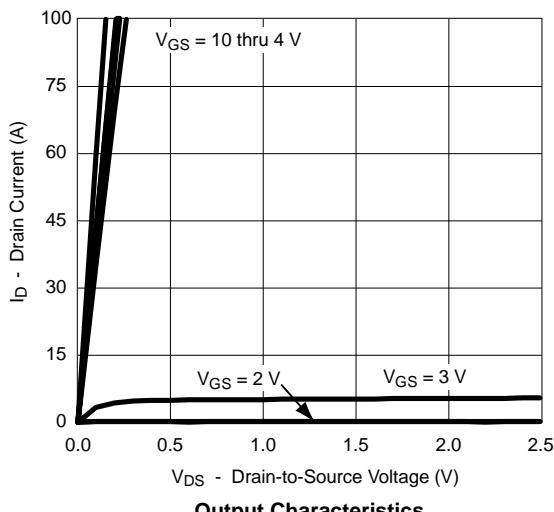
| Parameter                                      | Symbol                         | Test Conditions  | Min .               | Typ.  | Max.      | Unit                       |
|--|--------------------------------|--|---------------------|-------|-----------|----------------------------|
| <b>Static</b>                                  |                                |  |                     |       |           |                            |
| Drain-Source Breakdown Voltage                 | $V_{DS}$                       | $V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$   | 30                  |       |           | V                          |
| $V_{DS}$ Temperature Coefficient               | $\Delta V_{DS}/T_J$            | $I_D = 250 \mu\text{A}$  |                     | 35    |           | $\text{mV}/^\circ\text{C}$ |
| $V_{GS(\text{th})}$ Temperature Coefficient    | $\Delta V_{GS(\text{th})}/T_J$ |  |                     | - 5.5 |           |                            |
| Gate-Source Threshold Voltage                  | $V_{GS(\text{th})}$            |  | 1.0                 |       | 2.5       | V                          |
| Gate-Source Leakage                            | $I_{GSS}$                      | $V_{DS} = 0 \text{ V}$ , $V_{GS} = \pm 20 \text{ V}$   |                     |       | $\pm 100$ | nA                         |
| Zero Gate Voltage Drain Current                | $I_{DSS}$                      | $V_{DS} = 30 \text{ V}$ , $V_{GS} = 0 \text{ V}$   |                     | 1     |           | $\mu\text{A}$              |
|  |                                | $V_{DS} = 30 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 55^\circ\text{C}$  |                     |       | 10        |                            |
| On-State Drain Current <sup>a</sup>            | $I_{D(\text{on})}$             | $V_{DS} \geq 5 \text{ V}$ , $V_{GS} = 10 \text{ V}$  | 80                  |       |           | A                          |
| Drain-Source On-State Resistance <sup>a</sup>  | $R_{DS(\text{on})}$            | $V_{GS} = 10 \text{ V}$ , $I_D = 32 \text{ A}$   |                     | 0.003 |           | $\Omega$                   |
|  |                                | $V_{GS} = 4.5 \text{ V}$ , $I_D = 29 \text{ A}$  |                     | 0.005 |           |                            |
| Forward Transconductance <sup>a</sup>          | $g_{fs}$                       | $V_{DS} = 15 \text{ V}$ , $I_D = 32 \text{ A}$   |                     | 130   |           | S                          |
| <b>Dynamic<sup>b</sup></b>                     |                                |  |                     |       |           |                            |
| Input Capacitance                              | $C_{iss}$                      | $V_{DS} = 12.5 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$   |                     |       | 3200      | $\text{pF}$                |
| Output Capacitance                             | $C_{oss}$                      |  |                     |       | 1025      |                            |
| Reverse Transfer Capacitance                   | $C_{rss}$                      |  |                     |       | 970       |                            |
| Total Gate Charge                              | $Q_g$                          | $V_{DS} = 15 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 32 \text{ A}$   |                     |       | 71        | $\text{nC}$                |
| Gate-Source Charge                             | $Q_{gs}$                       | $V_{DS} = 15 \text{ V}$ , $V_{GS} = 4.5 \text{ V}$ , $I_D = 29 \text{ A}$  |                     |       | 61.5      |                            |
| Gate-Drain Charge                              | $Q_{gd}$                       |  |                     |       | 34        |                            |
| Gate Resistance                                | $R_g$                          |  | $f = 1 \text{ MHz}$ |       | 29        |                            |
| Turn-On Delay Time                             | $t_{d(\text{on})}$             | $V_{DD} = 15 \text{ V}$ , $R_L = 0.555 \Omega$<br>$I_D \geq 27 \text{ A}$ , $V_{GEN} = 10 \text{ V}$ , $R_g = 1 \Omega$  |                     | 1.4   | 2.1       | $\Omega$                   |
| Rise Time                                      | $t_r$                          |  |                     | 18    | 27        | $\text{ns}$                |
| Turn-Off Delay Time                            | $t_{d(\text{off})}$            |  |                     | 11    | 17        |                            |
| Fall Time                                      | $t_f$                          |  |                     | 70    | 105       |                            |
| Turn-On Delay Time                             | $t_{d(\text{on})}$             |  |                     | 10    | 15        |                            |
| Rise Time                                      | $t_r$                          | $V_{DD} = 15 \text{ V}$ , $R_L = 0.625 \Omega$<br>$I_D \geq 24 \text{ A}$ , $V_{GEN} = 4.5 \text{ V}$ , $R_g = 1 \Omega$ |                     | 55    | 83        | $\text{ns}$                |
| Turn-Off Delay Time                            | $t_{d(\text{off})}$            |  |                     | 180   | 270       |                            |
| Fall Time                                      | $t_f$                          |  |                     | 55    | 83        |                            |
|  |                                |  |                     | 12    | 18        |                            |
| <b>Drain-Source Body Diode Characteristics</b> |                                |  |                     |       |           |                            |
| Continuous Source-Drain Diode Current          | $I_S$                          | $T_C = 25^\circ\text{C}$   |                     |       | 80        | $\text{A}$                 |
| Pulse Diode Forward Current <sup>a</sup>       | $I_{SM}$                       |  |                     |       | 100       |                            |
| Body Diode Voltage                             | $V_{SD}$                       | $I_S = 22 \text{ A}$   |                     | 0.8   | 1.2       | V                          |
| Body Diode Reverse Recovery Time               | $t_{rr}$                       | $I_F = 20 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ , $T_J = 25^\circ\text{C}$                                    |                     | 52    | 78        | $\text{ns}$                |
| Body Diode Reverse Recovery Charge             | $Q_{rr}$                       |  |                     | 70.2  | 105       | $\text{nC}$                |
| Reverse Recovery Fall Time                     | $t_a$                          |  |                     | 27    |           | $\text{ns}$                |
| Reverse Recovery Rise Time                     | $t_b$                          |  |                     | 25    |           |                            |

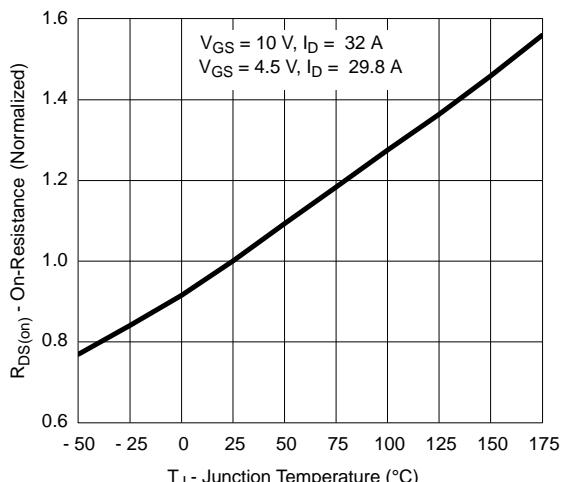
Notes:

a. Pulse test; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2\%$ .

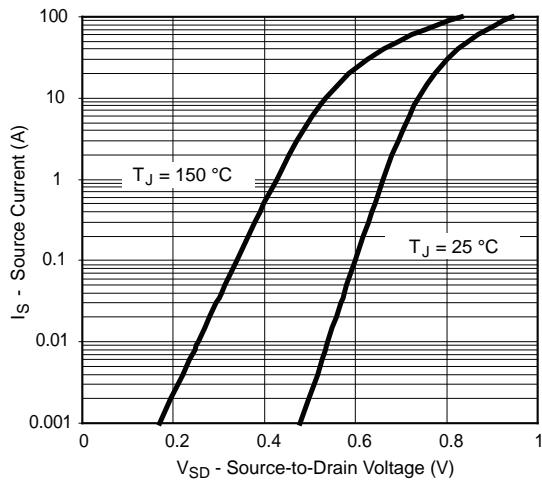
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

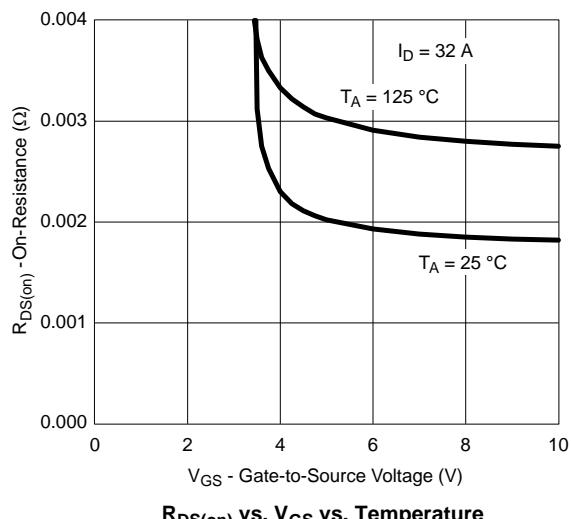
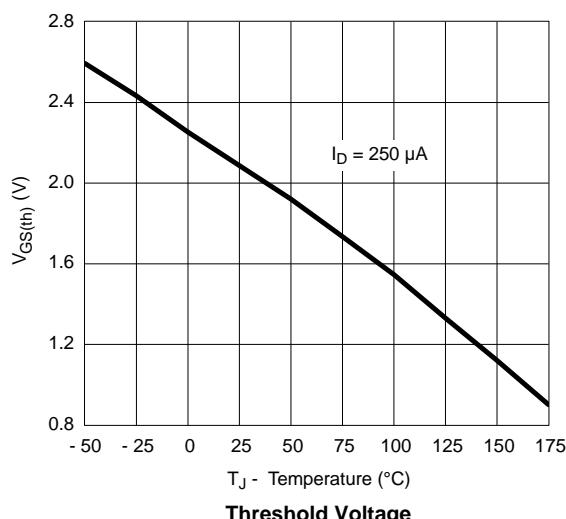
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)


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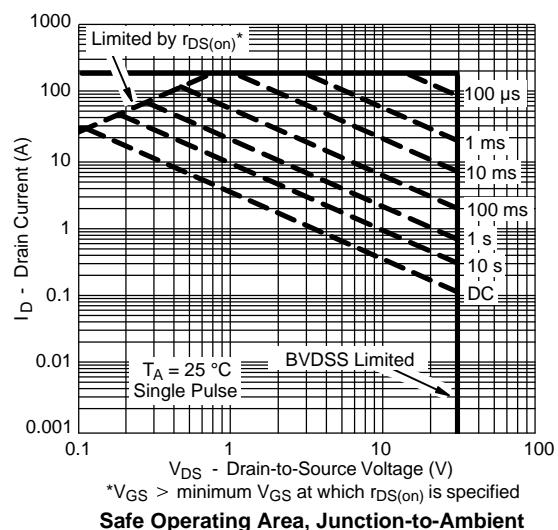
On-Resistance vs. Junction Temperature



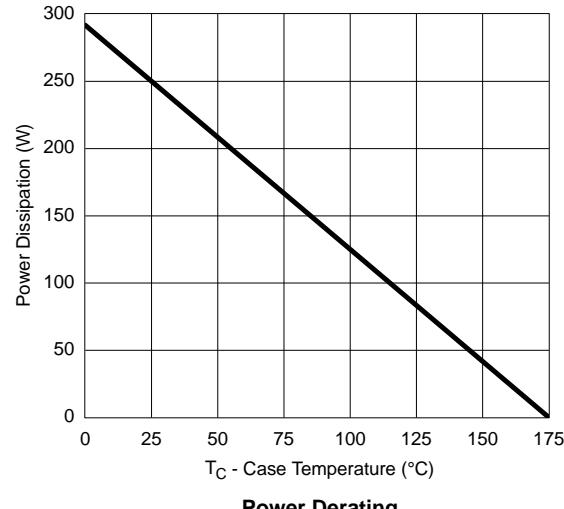
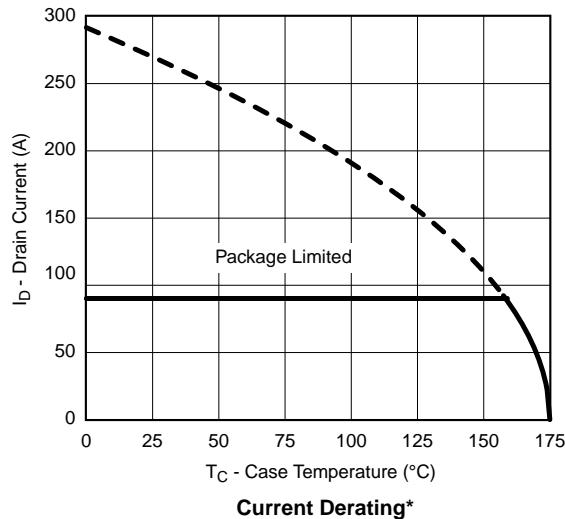
Forward Diode Voltage vs. Temperature

 $R_{DS(on)}$  vs.  $V_{GS}$  vs. Temperature

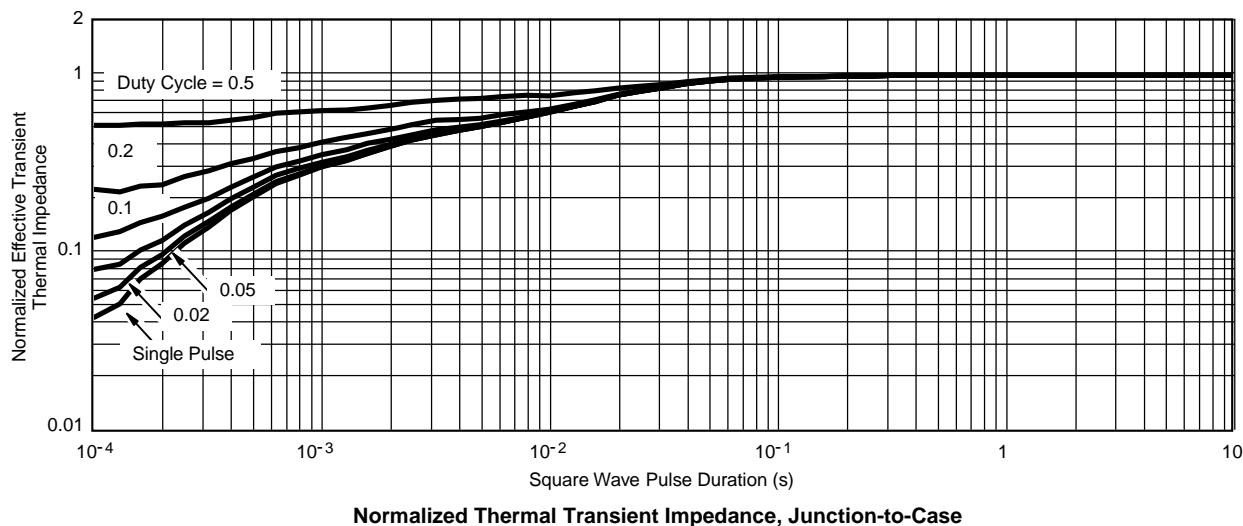
Threshold Voltage



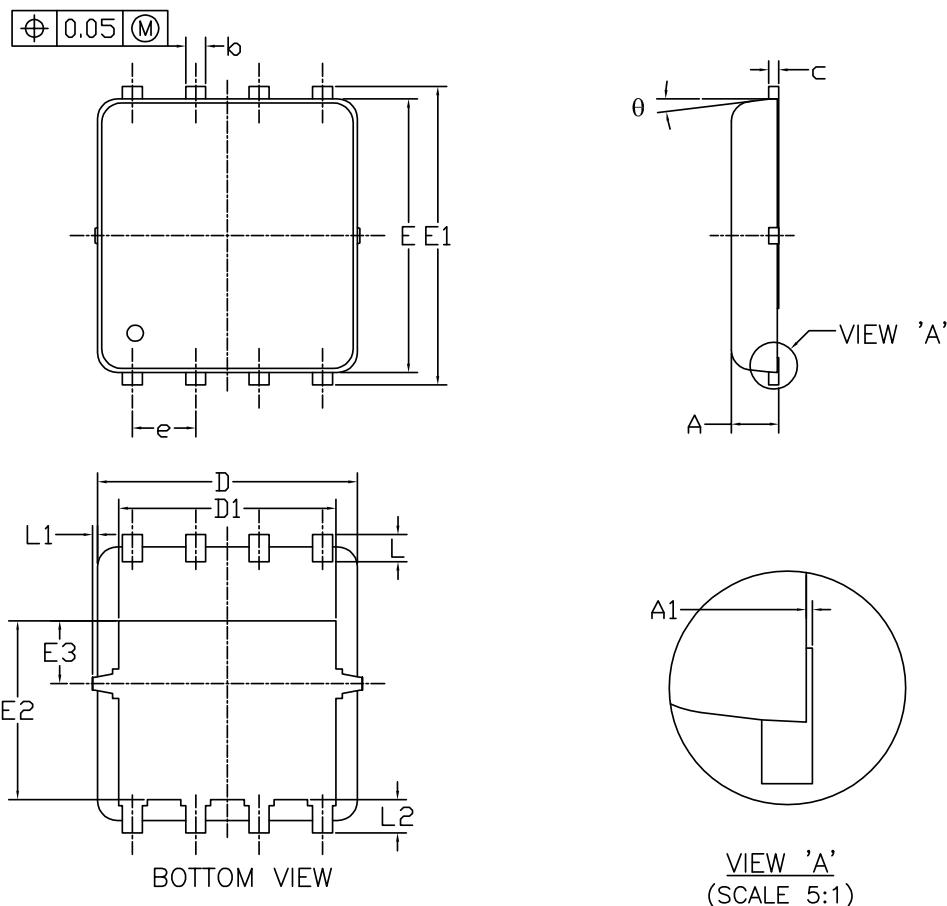
Safe Operating Area, Junction-to-Ambient

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)


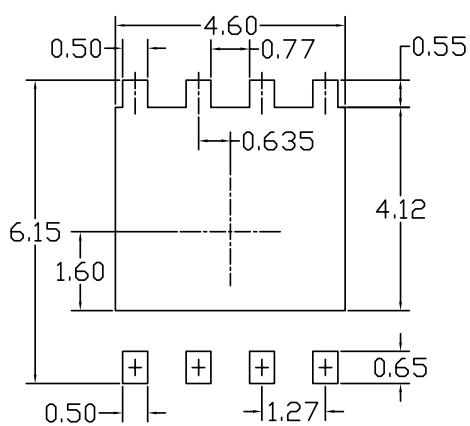
\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



## DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN



## RECOMMENDED LAND PATTERN



UNIT: mm

## NOTE

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.  
MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
2. CONTROLLING DIMENSION IS MILLIMETER.  
CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

| SYMBOLS | DIMENSIONS IN MILLIMETERS |       |       | DIMENSIONS IN INCHES |       |       |
|---------|---------------------------|-------|-------|----------------------|-------|-------|
|         | MIN                       | NOM   | MAX   | MIN                  | NOM   | MAX   |
| A       | 0.85                      | 0.95  | 1.00  | 0.033                | 0.037 | 0.039 |
| A1      | 0.00                      | ---   | 0.05  | 0.000                | ---   | 0.002 |
| b       | 0.30                      | 0.40  | 0.50  | 0.012                | 0.016 | 0.020 |
| c       | 0.15                      | 0.20  | 0.25  | 0.006                | 0.008 | 0.010 |
| D       | 5.10                      | 5.20  | 5.30  | 0.201                | 0.205 | 0.209 |
| D1      | 4.25                      | 4.35  | 4.45  | 0.167                | 0.171 | 0.175 |
| E       | 5.45                      | 5.55  | 5.65  | 0.215                | 0.219 | 0.222 |
| E1      | 5.95                      | 6.05  | 6.15  | 0.234                | 0.238 | 0.242 |
| E2      | 3.525                     | 3.625 | 3.725 | 0.139                | 0.143 | 0.147 |
| E3      | 1.175                     | 1.275 | 1.375 | 0.046                | 0.050 | 0.054 |
| e       | 1.27 BSC                  |       |       | 0.050 BSC            |       |       |
| L       | 0.45                      | 0.55  | 0.65  | 0.018                | 0.022 | 0.026 |
| L1      | 0                         | ---   | 0.15  | 0                    | ---   | 0.006 |
| L2      | 0.68 REF                  |       |       | 0.027 REF            |       |       |
| θ       | 0°                        | ---   | 10°   | 0°                   | ---   | 10°   |

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